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FORM PTO-1449		U.S. D. ARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCK			0 5 New Application		
LIS	T OF I	REFERENCES CIT	ED BY APPLICA	NT	APPLICANT Juha-Pekka K	OSKINEN	et a	ıl.		
	FILING DATE			GROUP						
(Use several sheets if necessary)					February 8, 2005			Unknown		
EXAMINER INITIAL		DOCUMENT NO.	U.S. PATE	NT DOCUMENT	'S ME	CLASS	1 -	SUB-	FILING DATE	
04	AA	2001/0049656 A1	December 6, 2001	Halkosaari et al.						
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**FOREIGN PATENT DOCUMENTS** 

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		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TR. YES	NSLA NO I	TION PART.
OA	AG	WO 01/63883 A2	30 August 2001	PCT			х		
OA	АН	WO 02/052833 A2	4 July 2002	PCT	-		х		
OA	Al	WO 02/052834 A1	2 <del>2 December 2000</del>	PCT	J		х		
	AJ		7/2002						
	AK								

		OTHER REFERENCES (Including A	uthor, Title, Date, Pertinent Pages, Etc.)				
A0	AL	Sebastian Zander "EVALUATION OF DIAMETER PROTOCOL AGAINST IPFIX Requirements"; September 2002; pa 1-12.					
	AM						
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EXAMINER		Ade	DATE CONSIDERED 10   13   05				

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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